

<b>Issue Classification</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/783,953	KUO, YI-LUNG	
				Examiner	Art Unit	
				Devin Hanan	3745	

ORIGINAL				CROSS REFERENCE(S)								
CLASS	SUBCLASS	CLASS	SUBCLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								
416	247R	415	220									
INTERNATIONAL CLASSIFICATION												
F	0	4	D	29/70								
				/								
				/								
				/								
				/								
<i>Devin Hanan 10/15/2005</i> Devin Hanan 10/15/2005 (Assistant Examiner) (Date)				<i>Edward Look 10/17/05</i> EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Primary Examiner) (Date)				Total Claims Allowed: 7				
<i>CGC 10/05</i> (Legal Instruments Examiner) (Date)								O.G. Print Claim(s)	O.G. Print Fig	1	4	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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